Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/614,343	BAJKO, GABOR	
Examiner	Art Unit	
John M. Frink	2142	

SEARCHED			
Class	Subclass	Date	Examiner
		:	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			-

SEAR (INCLUDING S	RCH NOTES EARCH STRATEGY	)
	DATE	EXMR
inventor	3/15/2007	JMF
assignee + text	3/15/2007	JMF
subclass + text	3/14/2007	JMF
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